S	Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination			
10/740,464	YOO ET AL.			
Examiner	Art Unit			
Anabel M. Ton	2875			

SEARCHED					
Subclass	Date	Examiner			
600-634	12/6/2006	АТ			
56-71					
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	Subclass 600-634	Subclass Date 600-634 12/6/2006 56-71			

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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